## Product Description

RFMD's RFSW2045D is an absorptive SP4T GaAs microwave monolithic integrated circuit (MMIC) switch designed using the RFMD FD05 $0.5 \mu \mathrm{~m}$ switch process. The RFSW2045D is developed for broadband communications, instrumentation and electronic warfare.


## Features

- Low Insertion Loss: 2.8 dB at 20 GHz
- High Isolation: 39dB at 20 GHz
- 19nS Switching Speed
- GaAs pHEMT Technology


## Applications

- Broadband Communications
- Test Instrumentation
- Fiber Optics
- Military
- Aerospace

| Parameter | Specification |  |  | Unit | Condition |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min. | Typ. | Max. |  |  |
| Operating Frequency | DC |  | 20 | GHz |  |
| Insertion Loss (0GHz to 5GHz) |  | 2.0 | 2.6 | dB | ON State |
| Insertion Loss ( 5 GHz to 10GHz) |  | 2.0 | 2.8 | dB | ON State |
| Insertion Loss (10GHz to 15GHz) |  | 2.3 | 3.1 | dB | ON State |
| Insertion Loss (15GHz to 20GHz) |  | 2.8 | 3.7 | dB | ON State |
| Isolation (0GHz to 5GHz) | 48 | 60 |  | dB | OFF State |
| Isolation (5GHz to 10GHz) | 44 | 50 |  | dB | OFF State |
| Isolation ( 10 GHz to 15 GHz ) | 40 | 43 |  | dB | OFF State |
| Isolation (15GHz to 20GHz) | 31 | 39 |  | dB | OFF State |
| Input Return Loss (DC to 20GHz) | 8 | 11 |  | dB | ON State |
| Output Return Loss (DC to 20GHz) | 11 | 14 |  | dB | ON State |
| IIP3 | 26 | 33 |  | dBm | 100 MHz spacing 2 dBm input |
| IIP2 | 49 | 54 |  | dBm | 100 MHz spacing 2 dBm input |
| Switching Speed |  | 19 | 25 | ns | 50\% control to 90\% RF |
| Control Current |  | 34 | 60 | uA | Sum of all control lines |
| Control Voltage | -3 | -5 | -8 | $V_{\text {DC }}$ |  |

## Absolute Maximum Ratings

| Parameter | Rating | Unit |
| :--- | :---: | :---: |
| Drain Bias Voltage (V. $\mathrm{V}_{\text {CTRL }}$ ) | -10 | $\mathrm{~V}_{\mathrm{DC}}$ |
| RF Input Power | +21 | dBm |
| Storage Temperature | -40 to +150 | ${ }^{\circ} \mathrm{C}$ |
| Operating Temperature | -40 to +85 | ${ }^{\circ} \mathrm{C}$ |
| ESD JESD22-A114 Human Body <br> Model (HBM) | Class 0 (All Pads) |  |

## 4 Caution! ESD sensitive device.

Exceeding any one or a combination of the Absolute Maximum Rating conditions may cause permanent damage to the device. Extended application of Absolute Maximum cause permanent damage to the device. Extended application of Absolute Maximum mance or functional operation of the device under Absolute Maximum Rating conditions is not implied.

RoHS status based on EUDirective 2002/95/EC (at time of this document revision),
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Typical Electrical Performance





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## Die Layout



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| Pad | Description | Interface Schematic |
| :---: | :---: | :---: |
| RFIN | RF input. This pad is DC coupled and matched to $50 \Omega$ from DC to 20 GHz . $50 \Omega$ microstrip transmission line on 0.127 mm ( 5 mil) thick alumina thin film substrate is recommended. |  |
| RF1, RF2, RF3, RF4 | RF output. This pad is DC coupled and matched to $50 \Omega$ from DC to 20 GHz . $50 \Omega$ microstrip transmission line on 0.127 mm ( 5 mil) thick alumina thin film substrate is recommended. |  |
| $\begin{gathered} \text { V1, } \\ \text { V2, } \\ \text { V3, } \\ \text { V4, } \\ \text { V5, } \\ \text { V6, } \\ \text { V7, v8 } \end{gathered}$ | DC control for switch operation. Nominal operating voltage is -5 V . |  |
| GND | Provides ground patch for probe measurements. |  |

Truth Table

| Control Line |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| V1 | V2 | V3 | V4 | V5 | V6 | V7 | V8 |  |
| Low | High | High | Low | High | Low | High | Low | RFIN to RF1 |
| High | Low | Low | High | High | Low | High | Low | RFIN to RF2 |
| High | Low | High | Low | Low | High | High | Low | RFIN to RF3 |
| High | Low | High | Low | High | Low | Low | High | RFIN to RF4 |
| High | Low | High | Low | High | Low | High | Low | RFOFF (high isolation) |

## Measurement Technique

All specifications and typical performances reported in this document were based on data taken with the equipment listed in the stated manner.

Data was taken using a temperature controlled probe station utilizing 150 um pitch GSG probes. The probes were placed on a ceramic coplanar to microstrip launch. The launch was then wire bonded to the die using two 1 mil bondwires. The spacing between the launch and the die was 200um, and the bondwire loop height was 100um. the thickness of the test interface was 125um (5mil).

The calibration included the probes and test interfaces, so that the measurement reference plane was at the point of bondwire attachment. Therefore, all data represents the part and accompanying bondwires.

Insertion Loss, Return Loss, and Isolation data were taken using an Agilent E8363B PNA.
IIP3 and IIP2 data were taken utilizing a pair of Agilent E8257D signal generators and an Agilent E4446A PSA.

## Preferred Assembly Instructions

GaAs devices are fragile and should be handled with great care. Specially designed collets should be used where possible. The back of the die is metallized and the recommended mounting method is by the use of conductive epoxy. Epoxy should be applied to the attachment surface uniformly and sparingly to avoid encroachment of epoxy onto the top face of the die. Ideally it should not exceed half the chip height. For automated dispense Ablestick LMISR4 is recommended and for manual dispense Ablestick 84-1 LMI or 84-1 LMIT are recommended. These should be cured at a temperature of $150^{\circ} \mathrm{C}$ for one hour in an oven especially set aside for epoxy curing only. If possible the curing oven should be flushed with dry nitrogen. The gold-tin (80\% Au $20 \% \mathrm{Sn}$ ) eutectic die attach has a melting point of approximately $280^{\circ} \mathrm{C}$ but the absolute temperature being used depends on the leadframe material used and the particular application. The time at maximum temperature should be kept to a minimum. This part has gold (Au) bond pads requiring the use of gold ( $99.99 \%$ pure) bondwire. It is recommended that 25.4 um diameter gold wire be used. Recommended lead bond technique is thermocompression wedge bonding with 0.001" ( $25 \mu \mathrm{~m}$ ) diameter wire. Bond force, time stage temperature, and ultrasonics are all critical parameters and the settings are dependent on the setup and application being used. Ultrasonic or thermosonic bonding is not recommended. Bonds should be made from the die first and then to the mounting substrate or package. The physical length of the bondwires should be minimized especially when making RF or ground connections.

## Handling Precautions

To avoid damage to the devices, care should be exercised during handling. Proper Electrostatic Discharge (ESD) precautions should be observed at all stages of storage, handling, assembly, and testing.

## ESD/MSL Rating

These devices should be treated as Class 0 ( 0 V to 250 V ) using the human body model as defined in JEDEC Standard No. 22A114. Further information on ESD control measures can be found in MIL-STD-1686 and MIL-HDBK-263. This is an unpackaged part and therefore no MSL rating applies.

## Ordering Information

| Part Number | Description | Delivery Method | Quantity |
| :---: | :---: | :---: | :---: |
| RFSW2045DS2 | DC to 20GHz GaAs SP4T Switch | Waffle Pack | 2 pc |
| RFSW2045DSB | DC to 20GHz GaAs SP4T Switch | Waffle Pack | 5 pc |
| RFSW2045DSQ | DC to 20GHz GaAs SP4T Switch | Waffle Pack | 25 pc |
| RFSW2045D | DC to 20GHz GaAs SP4T Switch | Waffle Pack | 100 pc |

